



## 256MB - 32Mx72 DDR SDRAM REGISTERED, w/PLL

### FEATURES

- Double-data-rate architecture
- Clock speeds: 100MHz and 133MHz
- Bi-directional data strobes (DQS)
- Differential clock inputs (CK & CK#)
- Programmable Read Latency 2,2,5 (clock)
- Programmable Burst Length (2,4,8)
- Programmable Burst type (sequential & interleave)
- Edge aligned data output, center aligned data input
- Auto and self refresh
- Serial presence detect
- Power Supply: 2.5V  $\pm$  0.20V
- JEDEC standard 184 pin DIMM package
  - Package height options:
    - JD3: 30.48mm (1.20")
    - AJD3: 28.70mm (1.13")

### DESCRIPTION

The W3EG7234S is a 32Mx72 Double Data Rate SDRAM memory module based on 128Mb DDR SDRAM component. The module consists of eighteen 32Mx4 DDR SDRAMs in 66 pin TSOP package mounted on a 184 Pin FR4 substrate.

Synchronous design allows precise cycle control with the use of system clock. Data I/O transactions are possible on both edges and Burst Lengths allow the same device to be useful for a variety of high bandwidth, high performance memory system applications.

\* This product is under development, is not qualified or characterized and is subject to change without notice.

### OPERATING FREQUENCIES

|                                      | DDR266 @CL=2 | DDR266 @CL=2.5 | DDR200 @CL=2 |
|--------------------------------------|--------------|----------------|--------------|
| Clock Speed                          | 133MHz       | 133MHz         | 100MHz       |
| CL-t <sub>RCD</sub> -t <sub>RP</sub> | 2-2-2        | 2.5-3-3        | 2-2-2        |



# WHITE ELECTRONIC DESIGNS

## W3EG7234S-D3 -JD3 -AJD3

PRELIMINARY

### PIN CONFIGURATIONS

| PIN | SYMBOL           | PIN | SYMBOL            | PIN | SYMBOL           | PIN | SYMBOL             |
|-----|------------------|-----|-------------------|-----|------------------|-----|--------------------|
| 1   | V <sub>REF</sub> | 47  | DQS8              | 93  | V <sub>SS</sub>  | 139 | V <sub>SS</sub>    |
| 2   | DQ0              | 48  | A0                | 94  | DQ4              | 140 | DQS17              |
| 3   | V <sub>SS</sub>  | 49  | CB2               | 95  | DQ5              | 141 | A10                |
| 4   | DQ1              | 50  | V <sub>SS</sub>   | 96  | V <sub>CCQ</sub> | 142 | CB6                |
| 5   | DQS0             | 51  | CB3               | 97  | DQS9             | 143 | V <sub>CCQ</sub>   |
| 6   | DQ2              | 52  | BA1               | 98  | DQ6              | 144 | CB7                |
| 7   | V <sub>CC</sub>  | 53  | DQ32              | 99  | DQ7              | 145 | V <sub>SS</sub>    |
| 8   | DQ3              | 54  | V <sub>CCQ</sub>  | 100 | V <sub>SS</sub>  | 146 | DQ36               |
| 9   | NC               | 55  | DQ33              | 101 | NC               | 147 | DQ37               |
| 10  | RESET#           | 56  | DQS4              | 102 | NC               | 148 | V <sub>CC</sub>    |
| 11  | V <sub>SS</sub>  | 57  | DQ34              | 103 | NC               | 149 | DQS13              |
| 12  | DQ8              | 58  | V <sub>SS</sub>   | 104 | V <sub>CCQ</sub> | 150 | DQ38               |
| 13  | DQ9              | 59  | BA0               | 105 | DQ12             | 151 | DQ39               |
| 14  | DQS1             | 60  | DQ35              | 106 | DQ13             | 152 | V <sub>SS</sub>    |
| 15  | V <sub>CCQ</sub> | 61  | DQ40              | 107 | DQS10            | 153 | DQ44               |
| 16  | *CK1             | 62  | V <sub>CCQ</sub>  | 108 | V <sub>CC</sub>  | 154 | RAS#               |
| 17  | *CK1#            | 63  | WE#               | 109 | DQ14             | 155 | DQ45               |
| 18  | V <sub>SS</sub>  | 64  | DQ41              | 110 | DQ15             | 156 | V <sub>CCQ</sub>   |
| 19  | DQ10             | 65  | CAS#              | 111 | *CKE1            | 157 | CS0#               |
| 20  | DQ11             | 66  | V <sub>SS</sub>   | 112 | V <sub>CCQ</sub> | 158 | *CS1#              |
| 21  | CKE0             | 67  | DQS5              | 113 | *BA2             | 159 | DQS14              |
| 22  | V <sub>CCQ</sub> | 68  | DQ42              | 114 | DQ20             | 160 | V <sub>SS</sub>    |
| 23  | DQ16             | 69  | DQ43              | 115 | A12              | 161 | DQ46               |
| 24  | DQ17             | 70  | V <sub>CC</sub>   | 116 | V <sub>SS</sub>  | 162 | DQ47               |
| 25  | DQS2             | 71  | *CK2#             | 117 | DQ21             | 163 | *CS3#              |
| 26  | V <sub>SS</sub>  | 72  | DQ48              | 118 | A11              | 164 | V <sub>CCQ</sub>   |
| 27  | A9               | 73  | DQ49              | 119 | DQS11            | 165 | DQ52               |
| 28  | DQ18             | 74  | V <sub>SS</sub>   | 120 | V <sub>CC</sub>  | 166 | DQ53               |
| 29  | A7               | 75  | *CK2#             | 121 | DQ22             | 167 | A13*               |
| 30  | V <sub>CCQ</sub> | 76  | *CK2              | 122 | A8               | 168 | V <sub>CC</sub>    |
| 31  | DQ19             | 77  | V <sub>CCQ</sub>  | 123 | DQ23             | 169 | DQS15              |
| 32  | A5               | 78  | DQS6              | 124 | V <sub>SS</sub>  | 170 | DQ54               |
| 33  | DQ24             | 79  | DQ50              | 125 | A6               | 171 | DQ55               |
| 34  | V <sub>SS</sub>  | 80  | DQ51              | 126 | DQ28             | 172 | V <sub>CCQ</sub>   |
| 35  | DQ25             | 81  | V <sub>SS</sub>   | 127 | DQ29             | 173 | NC                 |
| 36  | DQS3             | 82  | V <sub>CCID</sub> | 128 | V <sub>CCQ</sub> | 174 | DQ60               |
| 37  | A4               | 83  | DQ56              | 129 | DQS12            | 175 | DQ61               |
| 38  | V <sub>CC</sub>  | 84  | DQ57              | 130 | A3               | 176 | V <sub>SS</sub>    |
| 39  | DQ26             | 85  | V <sub>CC</sub>   | 131 | DQ30             | 177 | DQS16              |
| 40  | DQ27             | 86  | DQS7              | 132 | V <sub>SS</sub>  | 178 | DQ62               |
| 41  | A2               | 87  | DQ58              | 133 | DQ31             | 179 | DQ63               |
| 42  | V <sub>SS</sub>  | 88  | DQ59              | 134 | CB4              | 180 | V <sub>CCQ</sub>   |
| 43  | A1               | 89  | V <sub>SS</sub>   | 135 | CB5              | 181 | SA0                |
| 44  | CB0              | 90  | NC                | 136 | V <sub>CCQ</sub> | 182 | SA1                |
| 45  | CB1              | 91  | SDA               | 137 | CK0              | 183 | SA2                |
| 46  | V <sub>CC</sub>  | 92  | SCL               | 138 | CK0#             | 184 | V <sub>CCSPD</sub> |

### PIN NAMES

|                    |                                     |
|--------------------|-------------------------------------|
| A0 – A12           | Address input (Multiplexed)         |
| BA0-BA1            | Bank Select Address                 |
| DQ0-DQ63           | Data Input/Output                   |
| CB0-CB7            | Check bits                          |
| DQS0-DQS17         | Data Strobe Input/Output            |
| CK0                | Clock Input                         |
| CK0#               | Clock Input                         |
| CKE0               | Clock Enable Input                  |
| CS0#               | Chip select Input                   |
| RAS#               | Row Address Strobe                  |
| CAS#               | Column Address Strobe               |
| WE#                | Write Enable                        |
| V <sub>CC</sub>    | Power Supply                        |
| V <sub>CCQ</sub>   | Power Supply for DQS                |
| V <sub>SS</sub>    | Ground                              |
| V <sub>REF</sub>   | Power Supply for Reference          |
| V <sub>CCSPD</sub> | Serial EEPROM Power Supply          |
| SDA                | Serial data I/O                     |
| SCL                | Serial clock                        |
| SA0-SA2            | Address in EEPROM                   |
| V <sub>CCID</sub>  | V <sub>CC</sub> Identification Flag |
| NC                 | No Connect                          |
| RESET#             | Reset Enable                        |

\* Not Used



*PRELIMINARY*

**NOTE:** All resistor values are 22 ohms unless otherwise specified

**ABSOLUTE MAXIMUM RATINGS**

| Parameter                                                     | Symbol                             | Value       | Units |
|---------------------------------------------------------------|------------------------------------|-------------|-------|
| Voltage on any pin relative to V <sub>SS</sub>                | V <sub>IN</sub> , V <sub>OUT</sub> | -0.5 to 3.6 | V     |
| Voltage on V <sub>CC</sub> supply relative to V <sub>SS</sub> | V <sub>CC</sub> , V <sub>CCQ</sub> | -1.0 to 3.6 | V     |
| Storage Temperature                                           | T <sub>STG</sub>                   | -55 to +150 | °C    |
| Power Dissipation                                             | P <sub>D</sub>                     | 27          | W     |
| Short Circuit Current                                         | I <sub>OS</sub>                    | 50          | mA    |

Note: Permanent device damage may occur if 'ABSOLUTE MAXIMUM RATINGS' are exceeded.  
Functional operation should be restricted to recommended operating condition.  
Exposure to higher than recommended voltage for extended periods of time could affect device reliability

**DC CHARACTERISTICS**0°C ≤ T<sub>A</sub> ≤ 70°C, V<sub>CC</sub> = 2.5V ± 0.2V

| Parameter           | Symbol           | Min                     | Max                     | Unit |
|---------------------|------------------|-------------------------|-------------------------|------|
| Supply Voltage      | V <sub>CC</sub>  | 2.3                     | 2.7                     | V    |
| Supply Voltage      | V <sub>CCQ</sub> | 2.3                     | 2.7                     | V    |
| Reference Voltage   | V <sub>REF</sub> | 1.15                    | 1.35                    | V    |
| Termination Voltage | V <sub>TT</sub>  | 1.15                    | 1.35                    | V    |
| Input High Voltage  | V <sub>IH</sub>  | V <sub>REF</sub> + 0.15 | V <sub>CCQ</sub> + 0.3  | V    |
| Input Low Voltage   | V <sub>IL</sub>  | -0.3                    | V <sub>REF</sub> - 0.15 | V    |
| Output High Voltage | V <sub>OH</sub>  | V <sub>TT</sub> + 0.76  | —                       | V    |
| Output Low Voltage  | V <sub>OL</sub>  | —                       | V <sub>TT</sub> - 0.76  | V    |

**CAPACITANCE**T<sub>A</sub> = 25°C, f = 1MHz, V<sub>CC</sub> = 2.5V

| Parameter                                     | Symbol           | Max  | Unit |
|-----------------------------------------------|------------------|------|------|
| Input Capacitance (A0-A12)                    | C <sub>IN1</sub> | 6.25 | pF   |
| Input Capacitance (RAS#, CAS#, WE#)           | C <sub>IN2</sub> | 6.25 | pF   |
| Input Capacitance (CKE0)                      | C <sub>IN3</sub> | 6.25 | pF   |
| Input Capacitance (CK0#, CK0)                 | C <sub>IN4</sub> | 5.5  | pF   |
| Input Capacitance (CS0#)                      | C <sub>IN5</sub> | 6.25 | pF   |
| Input Capacitance (DQS0-DQS17)                | C <sub>IN6</sub> | 13   | pF   |
| Input Capacitance (BA0-BA1)                   | C <sub>IN7</sub> | 6.25 | pF   |
| Data input/output capacitance (DQ0-DQ63)(DQS) | C <sub>OUT</sub> | 13   | pF   |
| Data input/output capacitance (CB0-CB7)       | C <sub>OUT</sub> | 13   | pF   |

**IDD SPECIFICATIONS AND TEST CONDITIONS**0°C ≤ T<sub>A</sub> ≤ 70°C, V<sub>CCQ</sub> = 2.5V ± 0.2V, V<sub>CC</sub> = 2.5V ± 0.2V

Includes PLL and Register Power

| Parameter                            | Symbol            | Rank 1 Conditions                                                                                                                                                                                                                                                   | DDR266@CL=2 Max | DDR266@CL=2.5 Max | DDR200@CL=2 Max | Units |
|--------------------------------------|-------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------|-------------------|-----------------|-------|
| Operating Current                    | I <sub>DD0</sub>  | One device bank; Active - Precharge; t <sub>RC</sub> = t <sub>RC</sub> (MIN); t <sub>CK</sub> = t <sub>CK</sub> (MIN); DQ, DM and DQS inputs changing once per clock cycle; Address and control inputs changing once every two cycles.                              | 2520            | 2385              | 2385            | mA    |
| Operating Current                    | I <sub>DD1</sub>  | One device bank; Active-Read-Precharge Burst = 2; t <sub>RC</sub> = t <sub>RC</sub> (MIN); t <sub>CK</sub> = t <sub>CK</sub> (MIN); I <sub>OUT</sub> = 0mA; Address and control inputs changing once per clock cycle.                                               | 2700            | 2520              | 2520            | mA    |
| Precharge Power-Down Standby Current | I <sub>DD2P</sub> | All device banks idle; Power-down mode; t <sub>CK</sub> = t <sub>CK</sub> (MIN); CKE = (low)                                                                                                                                                                        | 54              | 54                | 54              | mA    |
| Idle Standby Current                 | I <sub>DD2F</sub> | CS# = High; All device banks idle; t <sub>CK</sub> = t <sub>CK</sub> (MIN); CKE = High; Address and other control inputs changing once per clock cycle. V <sub>IN</sub> = V <sub>REF</sub> for DQ, DQS and DM.                                                      | 1120            | 1030              | 1030            | mA    |
| Active Power-Down Standby Current    | I <sub>DD3P</sub> | One device bank active; Power-Down mode; t <sub>CK</sub> (MIN); CKE = (low)                                                                                                                                                                                         | 450             | 360               | 360             | mA    |
| Active Standby Current               | I <sub>DD3N</sub> | CS# = High; CKE = High; One device bank; Active-Precharge; t <sub>RC</sub> = t <sub>RAS</sub> (MAX); t <sub>CK</sub> = t <sub>CK</sub> (MIN); DQ, DM and DQS inputs changing twice per clock cycle; Address and other control inputs changing once per clock cycle. | 1210            | 1120              | 1120            | mA    |
| Operating Current                    | I <sub>DD4R</sub> | Burst = 2; Reads; Continuous burst; One device bank active; Address and control inputs changing once per clock cycle; t <sub>CK</sub> = t <sub>CK</sub> (MIN); I <sub>OUT</sub> = 0mA.                                                                              | 2745            | 2610              | 2610            | mA    |
| Operating Current                    | I <sub>DD4W</sub> | Burst = 2; Writes; Continuous burst; One device bank active; Address and control inputs changing once per clock cycle; t <sub>CK</sub> = t <sub>CK</sub> (MIN); DQ, DM and DQS inputs changing once per clock cycle.                                                | 2700            | 2565              | 2565            | mA    |
| Auto Refresh Current                 | I <sub>DD5</sub>  | t <sub>RC</sub> = t <sub>RC</sub> (MIN)                                                                                                                                                                                                                             | 3770            | 3680              | 3645            | mA    |
| Self Refresh Current                 | I <sub>DD6</sub>  | CKE ≤ 0.2V                                                                                                                                                                                                                                                          | 329             | 311               | 346             | mA    |
| Operating Current                    | I <sub>DD7A</sub> | Four bank interleaving Reads (BL=4) with auto precharge with t <sub>RC</sub> =t <sub>RC</sub> (MIN); t <sub>CK</sub> =t <sub>CK</sub> (MIN); Address and control inputs change only during Active Read or Write commands.                                           | 4860            | 4770              | 4770            | mA    |



### IDD SPECIFICATIONS AND TEST CONDITIONS

0°C ≤ T<sub>A</sub> ≤ 70°C, V<sub>CCQ</sub> = 2.5V ± 0.2V, V<sub>CC</sub> = 2.5V ± 0.2V

Includes DDR SDRAM components only

| Parameter                            | Symbol            | Rank 1 Conditions                                                                                                                                                                                                                                                   | DDR266@CL=2 Max | DDR266@CL=2.5 Max | DDR200@CL=2 Max | Units |
|--------------------------------------|-------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------|-------------------|-----------------|-------|
| Operating Current                    | I <sub>DD0</sub>  | One device bank; Active - Precharge; t <sub>RC</sub> = t <sub>RC</sub> (MIN); t <sub>CK</sub> = t <sub>CK</sub> (MIN); DQ, DM and DQS inputs changing once per clock cycle; Address and control inputs changing once every two cycles.                              | 1935            | 1800              | 1800            | mA    |
| Operating Current                    | I <sub>DD1</sub>  | One device bank; Active-Read-Precharge Burst = 2; t <sub>RC</sub> = t <sub>RC</sub> (MIN); t <sub>CK</sub> = t <sub>CK</sub> (MIN); I <sub>OUT</sub> = 0mA; Address and control inputs changing once per clock cycle.                                               | 2115            | 1935              | 1935            | mA    |
| Precharge Power-Down Standby Current | I <sub>DD2P</sub> | All device banks idle; Power-down mode; t <sub>CK</sub> = t <sub>CK</sub> (MIN); CKE = (low)                                                                                                                                                                        | 54              | 54                | 54              | mA    |
| Idle Standby Current                 | I <sub>DD2F</sub> | CS# = High; All device banks idle; t <sub>CK</sub> = t <sub>CK</sub> (MIN); CKE = High; Address and other control inputs changing once per clock cycle. V <sub>IN</sub> = V <sub>REF</sub> for DQ, DQS and DM.                                                      | 810             | 720               | 720             | mA    |
| Active Power-Down Standby Current    | I <sub>DD3P</sub> | One device bank active; Power-Down mode; t <sub>CK</sub> (MIN); CKE = (low)                                                                                                                                                                                         | 450             | 360               | 360             | mA    |
| Active Standby Current               | I <sub>DD3N</sub> | CS# = High; CKE = High; One device bank; Active-Precharge; t <sub>RC</sub> = t <sub>RAS</sub> (MAX); t <sub>CK</sub> = t <sub>CK</sub> (MIN); DQ, DM and DQS inputs changing twice per clock cycle; Address and other control inputs changing once per clock cycle. | 900             | 810               | 810             | mA    |
| Operating Current                    | I <sub>DD4R</sub> | Burst = 2; Reads; Continuous burst; One device bank active; Address and control inputs changing once per clock cycle; t <sub>CK</sub> = t <sub>CK</sub> (MIN); I <sub>OUT</sub> = 0mA.                                                                              | 2160            | 2025              | 2025            | mA    |
| Operating Current                    | I <sub>DD4W</sub> | Burst = 2; Writes; Continuous burst; One device bank active; Address and control inputs changing once per clock cycle; t <sub>CK</sub> = t <sub>CK</sub> (MIN); DQ, DM and DQS inputs changing once per clock cycle.                                                | 2115            | 1980              | 1980            | mA    |
| Auto Refresh Current                 | I <sub>DD5</sub>  | t <sub>RC</sub> = t <sub>RC</sub> (MIN)                                                                                                                                                                                                                             | 3150            | 3060              | 3060            | mA    |
| Self Refresh Current                 | I <sub>DD6</sub>  | CKE ≤ 0.2V                                                                                                                                                                                                                                                          | 54              | 36                | 36              | mA    |
| Operating Current                    | I <sub>DD7A</sub> | Four bank interleaving Reads (BL=4) with auto precharge with t <sub>RC</sub> =t <sub>RC</sub> (MIN); t <sub>CK</sub> =t <sub>CK</sub> (MIN); Address and control inputs change only during Active Read or Write commands.                                           | 4275            | 4185              | 4185            | mA    |



### DETAILED TEST CONDITIONS FOR DDR SDRAM I<sub>DD1</sub> & I<sub>DD7A</sub>

#### I<sub>DD1</sub> : OPERATING CURRENT: ONE BANK

1. Typical Case: V<sub>CC</sub> = 2.5V, T = 25°C
2. Worst Case: V<sub>CC</sub> = 2.7V, T = 10°C
3. Only one bank is accessed with t<sub>RC</sub> (min), Burst Mode, Address and Control inputs on NOP edge are changing once per clock cycle. I<sub>OUT</sub> = 0mA
4. Timing patterns
  - DDR200 (100MHz, CL = 2) : t<sub>CK</sub> = 10ns, CL2, BL = 4, t<sub>RCD</sub> = 2\*t<sub>CK</sub>, t<sub>RAg</sub> = 5\*t<sub>CK</sub>  
Read: A0 N R0 N N P0 N A0 N - repeat the same timing with random address changing; 50% of data changing at every burst
  - DDR266 (133MHz, CL = 2.5) : t<sub>CK</sub> = 7.5ns, CL = 2.5, BL = 4, t<sub>RCD</sub> = 3\*t<sub>CK</sub>, t<sub>RC</sub> = 9\*t<sub>CK</sub>, t<sub>RAg</sub> = 5\*t<sub>CK</sub>  
Read: A0 N N R0 N P0 N N A0 N - repeat the same timing with random address changing; 50% of data changing at every burst
  - DDR266 (133MHz, CL = 2) : t<sub>CK</sub> = 7.5ns, CL = 2, BL = 4, t<sub>RCD</sub> = 3\*t<sub>CK</sub>, t<sub>RC</sub> = 9\*t<sub>CK</sub>, t<sub>RAg</sub> = 5\*t<sub>CK</sub>  
Read: A0 N N R0 N P0 N N A0 N - repeat the same timing with random address changing; 50% of data changing at every burst

#### I<sub>DD7A</sub>: OPERATING CURRENT: FOUR BANKS

1. Typical Case: V<sub>CC</sub> = 2.5V, T = 25°C
2. Worst Case: V<sub>CC</sub> = 2.7V, T = 10°C
3. Four banks are being interleaved with t<sub>RC</sub> (min), Burst Mode, Address and Control inputs on NOP edge are not changing.  
I<sub>OUT</sub> = 0mA
4. Timing patterns
  - DDR200 (100MHz, CL = 2) : t<sub>CK</sub> = 10ns, CL2, BL = 4, t<sub>RRD</sub> = 2\*t<sub>CK</sub>, t<sub>RCD</sub> = 3\*t<sub>CK</sub>, Read with autoprecharge  
Read: A0 N A1 R0 A2 R1 A3 R2 A0 R3 A1 R0 - repeat the same timing with random address changing; 100% of data changing at every burst
  - DDR266 (133MHz, CL = 2.5) : t<sub>CK</sub> = 7.5ns, CL = 2.5, BL = 4, t<sub>RRD</sub> = 3\*t<sub>CK</sub>, t<sub>RCD</sub> = 3\*t<sub>CK</sub> Read with autoprecharge  
Read: A0 N A1 R0 A2 R1 A3 R2 N R3 A0 N A1 R0 - repeat the same timing with random address changing; 100% of data changing at every burst
  - DDR266 (133MHz, CL = 2) : t<sub>CK</sub> = 7.5ns, CL2 = 2, BL = 4, t<sub>RRD</sub> = 2\*t<sub>CK</sub>, t<sub>RCD</sub> = 3\*t<sub>CK</sub>  
Read: A0 N A1 R0 A2 R1 A3 R2 N R3 A0 N A1 R0 - repeat the same timing with random address changing; 100% of data changing at every burst

Legend: A = Activate, R = Read, W = Write, P = Precharge, N = NOP

A (0-3) = Activate Bank 0-3

R (0-3) = Read Bank 0-3



WHITE ELECTRONIC DESIGNS

**W3EG7234S-D3**  
**-JD3**  
**-AJD3**

PRELIMINARY

# **DDR SDRAM COMPONENT ELECTRICAL CHARACTERISTICS AND RECOMMENDED AC OPERATING CONDITIONS**

$0^{\circ}\text{C} \leq T_A \leq +70^{\circ}\text{C}$ ;  $V_{CC} = +2.5\text{V} \pm 0.2\text{V}$ ,  $V_{CCQ} = +2.5\text{V} \pm 0.2\text{V}$

| AC Characteristics                                       |        |                | 262/265          |         | 202              |         |       |       |
|----------------------------------------------------------|--------|----------------|------------------|---------|------------------|---------|-------|-------|
| Parameter                                                |        | Symbol         | Min              | Max     | Min              | Max     | Units | Notes |
| Access window of DQs from CK, CK#                        |        | $t_{AC}$       | -0.75            | +0.75   | -0.8             | +0.8    | ns    |       |
| CK high-level width                                      |        | $t_{CH}$       | 0.45             | 0.55    | 0.45             | 0.55    | tck   | 16    |
| CK low-level width                                       |        | $t_{CL}$       | 0.45             | 0.55    | 0.45             | 0.55    | tck   | 16    |
| Clock cycle time                                         | CL=2.5 | $t_{CK} (2.5)$ | 7.5              | 13      | 8                | 13      | ns    | 22    |
|                                                          | CL=2   | $t_{CK} (2)$   | 7.5/10           | 13      | 10               | 13      | ns    | 22    |
| DQ and DM input hold time relative to DQS                |        | $t_{DH}$       | 0.5              |         | 0.6              |         | ns    | 14,17 |
| DQ and DM input setup time relative to DQS               |        | $t_{DS}$       | 0.5              |         | 0.6              |         | ns    | 14,17 |
| DQ and DM input pulse width (for each input)             |        | $t_{DIPW}$     | 1.75             |         | 2                |         | ns    | 17    |
| Access window of DQS from CK, CK#                        |        | $t_{DQSCK}$    | -0.75            | +0.75   | -0.8             | +0.8    | ns    |       |
| DQS input high pulse width                               |        | $t_{DQSH}$     | 0.35             |         | 0.35             |         | tck   |       |
| DQS input low pulse width                                |        | $t_{DQSL}$     | 0.35             |         | 0.35             |         | tck   |       |
| DQS-DQ skew, DQS to last DQ valid, per group, per access |        | $t_{DQSQ}$     |                  | 0.5     |                  | 0.6     | ns    | 13,14 |
| Write command to first DQS latching transition           |        | $t_{DQSS}$     | 0.75             | 1.25    | 0.75             | 1.25    | tck   |       |
| DQS falling edge to CK rising - setup time               |        | $t_{DSSH}$     | 0.2              |         | 0.2              |         | tck   |       |
| DQS falling edge from CK rising - hold time              |        | $t_{DSH}$      | 0.2              |         | 0.2              |         | tck   |       |
| Half clock period                                        |        | $t_{HP}$       | $t_{CH}, t_{CL}$ |         | $t_{CH}, t_{CL}$ |         | ns    | 18    |
| Data-out high-impedance window from CK, CK#              |        | $t_{HZ}$       |                  | +0.75   |                  | +0.8    | ns    | 8,19  |
| Data-out low-impedance window from CK, CK#               |        | $t_{LZ}$       | -0.75            |         | -0.8             |         | ns    | 8,20  |
| Address and control input hold time (fast slew rate)     |        | $t_{Hf}$       | 0.90             |         | 1.1              |         | ns    | 6     |
| Address and control input set-up time (fast slew rate)   |        | $t_{Sf}$       | 0.90             |         | 1.1              |         | ns    | 6     |
| Address and control input hold time (slow slew rate)     |        | $t_{Hs}$       | 1                |         | 1.1              |         | ns    | 6     |
| Address and control input setup time (slow slew rate)    |        | $t_{Ss}$       | 1                |         | 1.1              |         | ns    | 6     |
| Address and control input pulse width (for each input)   |        | $t_{IPW}$      | 2.2              |         | 2.2              |         | ns    |       |
| LOAD MODE REGISTER command cycle time                    |        | $t_{MRD}$      | 15               |         | 16               |         | ns    |       |
| DQ-DQS hold, DQS to first DQ to go non-valid, per access |        | $t_{QH}$       | $t_{HP}-t_{QHS}$ |         | $t_{HP}-t_{QHS}$ |         | ns    | 13,14 |
| Data hold skew factor                                    |        | $t_{QHS}$      |                  | 0.75    |                  | 1       | ns    |       |
| ACTIVE to PRECHARGE command                              |        | $t_{RAS}$      | 40               | 120,000 | 40               | 120,000 | ns    | 15    |
| ACTIVE to READ with Auto precharge command               |        | $t_{RAP}$      | 15               |         | 20               |         | ns    |       |
| ACTIVE to ACTIVE/AUTO REFRESH command period             |        | $t_{RC}$       | 60               |         | 70               |         | ns    |       |
| AUTO REFRESH command period                              |        | $t_{RFC}$      | 75               |         | 80               |         | ns    | 21    |

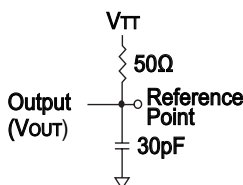


**DDR SDRAM COMPONENT ELECTRICAL CHARACTERISTICS AND  
RECOMMENDED AC OPERATING CONDITIONS (continued)** $0^{\circ}\text{C} \leq T_A \leq +70^{\circ}\text{C}$ ;  $V_{CC} = +2.5\text{V} \pm 0.2\text{V}$ ,  $V_{CCQ} = +2.5\text{V} \pm 0.2\text{V}$ 

| AC Characteristics                     |             | 262/265             |       | 202                 |       |               |       |
|----------------------------------------|-------------|---------------------|-------|---------------------|-------|---------------|-------|
| Parameter                              | Symbol      | Min                 | Max   | Min                 | Max   | Units         | Notes |
| ACTIVE to READ or WRITE delay          | $t_{RCD}$   | 15                  |       | 20                  |       | ns            |       |
| PRECHARGE command period               | $t_{RP}$    | 15                  |       | 20                  |       | ns            |       |
| DQS read preamble                      | $t_{RPRE}$  | 0.9                 | 1.1   | 0.9                 | 1.1   | tck           | 19    |
| DQS read postamble                     | $t_{RPST}$  | 0.4                 | 0.6   | 0.4                 | 0.6   | tck           |       |
| ACTIVE bank a to ACTIVE bank b command | $t_{RRD}$   | 12                  |       | 15                  |       | ns            |       |
| DQS write preamble                     | $t_{WPRE}$  | 0.25                |       | 0.25                |       | tck           |       |
| DQS write preamble setup time          | $t_{WPRES}$ | 0                   |       | 0                   |       | ns            | 10,11 |
| DQS write postamble                    | $t_{WPST}$  | 0.4                 | 0.6   | 0.4                 | 0.6   | tck           | 9     |
| Write recovery time                    | $t_{WR}$    | 15                  |       | 15                  |       | ns            |       |
| Internal WRITE to READ command delay   | $t_{WTR}$   | 1                   |       | 1                   |       | tck           |       |
| Data valid output window               | NA          | $t_{QH} - t_{DQSQ}$ |       | $t_{QH} - t_{DQSQ}$ |       | ns            | 13    |
| REFRESH to REFRESH command interval    | $t_{REFC}$  |                     | 140.6 |                     | 140.6 | $\mu\text{s}$ | 12    |
| Average periodic refresh interval      | $t_{REFI}$  |                     | 15.6  |                     | 15.6  | $\mu\text{s}$ | 12    |
| Terminating voltage delay to $V_{CC}$  | $t_{VTD}$   | 0                   |       | 0                   |       | ns            |       |
| Exit SELF REFRESH to non-READ command  | $t_{XSNR}$  | 75                  |       | 80                  |       | ns            |       |
| Exit SELF REFRESH to READ command      | $t_{XSRD}$  | 200                 |       | 200                 |       | tck           |       |

**Notes**

1. All voltages referenced to  $V_{SS}$
2. Tests for AC timing,  $I_{DD}$ , and electrical AC and DC characteristics may be conducted at normal reference / supply voltage levels, but the related specifications and device operations are guaranteed for the full voltage range specified.
3. Outputs are measured with equivalent load:



4. AC timing and  $I_{DD}$  tests may use a  $V_{IL}$ -to- $V_{IH}$  swing of up to 1.5V in the test environment, but input timing is still referenced to  $V_{REF}$  (or to the crossing point for CK/CK#), and parameter specifications are guaranteed for the specified AC input levels under normal use conditions. The minimum slew rate for the input signals used to test the device is 1V/ns in the range between  $V_{IL}(AC)$  and  $V_{IH}(AC)$ .
5. The AC and DC input level specifications are defined in the SSTL\_2 standard (i.e., the receiver will effectively switch as a result of the signal crossing the AC input level, and will remain in that state as long as the signal does not ring back above [below] the DC input LOW [high] level).
6. For slew rates less than 1V/ns and greater than or equal to 0.5V/ns. If the slew rate is less than 0.5V/ns, timing must be derated:  $t_{IS}$  has an additional 50ps per each 100mV/ns reduction in slew rate from the 500mV/ns.  $t_{IH}$  has 0ps added, that is, it remains constant. If the slew rate exceeds 4.5V/ns, functionality is uncertain. For 403 and 335, slew rates must be greater than or equal to 0.5V/ns.
7. Inputs are not recognized as valid until  $V_{REF}$  stabilizes. Exception: during the period before  $V_{REF}$  stabilizes,  $CKE \leq 0.3 \times V_{CCQ}$  is recognized as LOW.
8.  $t_{HZ}$  and  $t_{LZ}$  transitions occur in the same access time windows as valid data transitions. These parameters are not referenced to a specific voltage level, but specify when the device output is no longer driving (HZ) and begins driving (LZ).
9. The intent of the "Don't Care" state after completion of the postamble is the DQS-driven signal should either be HIGH, LOW, or high-Z, and that any signal transition within the input switching region must follow valid input requirements. That is, if DQS transitions HIGH (above  $V_{IHDC}$  (MIN)) then it must not transition LOW (below  $V_{IHDC}$ ) prior to  $t_{DQSH}$  (MIN).
10. This is not a device limit. The device will operate with a negative value, but system performance could be degraded due to bus turnaround.
11. It is recommended that DQS be valid (HIGH or LOW) on or before the WRITE command. The case shown (DQS going from High-Z to logic LOW) applies when no WRITES were previously in progress on the bus. If a previous WRITE was in progress, DQS could be high during this time, depending on  $t_{BOSS}$ .
12. The refresh period is 64ms. This equates to an average refresh rate of 15.625 $\mu$ s. However, an AUTO REFRESH command must be asserted at least once every 140.6 $\mu$ s; burst refreshing or posting by the DRAM controller greater than eight refresh cycles is not allowed.
13. The valid data window is derived by achieving other specifications -  $t_{HP}$  ( $t_{CK}/2$ ),  $t_{DQSQ}$ , and  $t_{QH}$  ( $t_{QH} = t_{HP} - t_{QHS}$ ). The data valid window derates directly proportional with the clock duty cycle and a practical data valid window can be derived. The clock is allowed a maximum duty cycled variation of 45/55. Functionality is uncertain when operating beyond a 45/55 ratio. The data valid window derating curves are provided below for duty cycles ranging between 50/50 and 45/55.
14. Referenced to each output group: x4 = DQS with DQ0-DQ3.
15. READs and WRITEs with auto precharge are not allowed to be issued until  $t_{RAS}$  (MIN) can be satisfied prior to the internal precharge command being issued.
16. JEDEC specifies CK and CK# input slew rate must be  $\geq 1V/ns$  (2V/ns differentially).
17. DQ and DM input slew rates must not deviate from DQS by more than 10%. If the DQ/DM/DQS slew rate is less than 0.5V/ns, timing must be derated: 50ps must be added to  $t_{DS}$  and  $t_{DH}$  for each 100mV/ns reduction in slew rate. If slew rates exceed 4V/ns, functionality is uncertain.
18.  $t_{HP}$  min is the lesser of  $t_{CL}$  min and  $t_{CH}$  min actually applied to the device CK and CK# inputs, collectively during bank active.
19.  $t_{HZ}$  (MAX) will prevail over the  $t_{DQSQ}$  (MAX) +  $t_{RPST}$  (MAX) condition.  $t_{LZ}$  (MIN) will prevail over  $t_{DQSQ}$  (MIN) + PRE (MAX) condition.
20. For slew rates greater than 1V/ns the (LZ) transition will start about 310ps earlier.
21. CKE must be active (High) during the entire time a refresh command is executed. That is, from the time the AUTO REFRESH command is registered, CKE must be active at each rising clock edge, until  $t_{RFC}$  has been satisfied.
22. Whenever the operating frequency is altered, not including jitter, the DLL is required to be reset. This is followed by 200 clock cycles (before READ commands).



WHITE ELECTRONIC DESIGNS

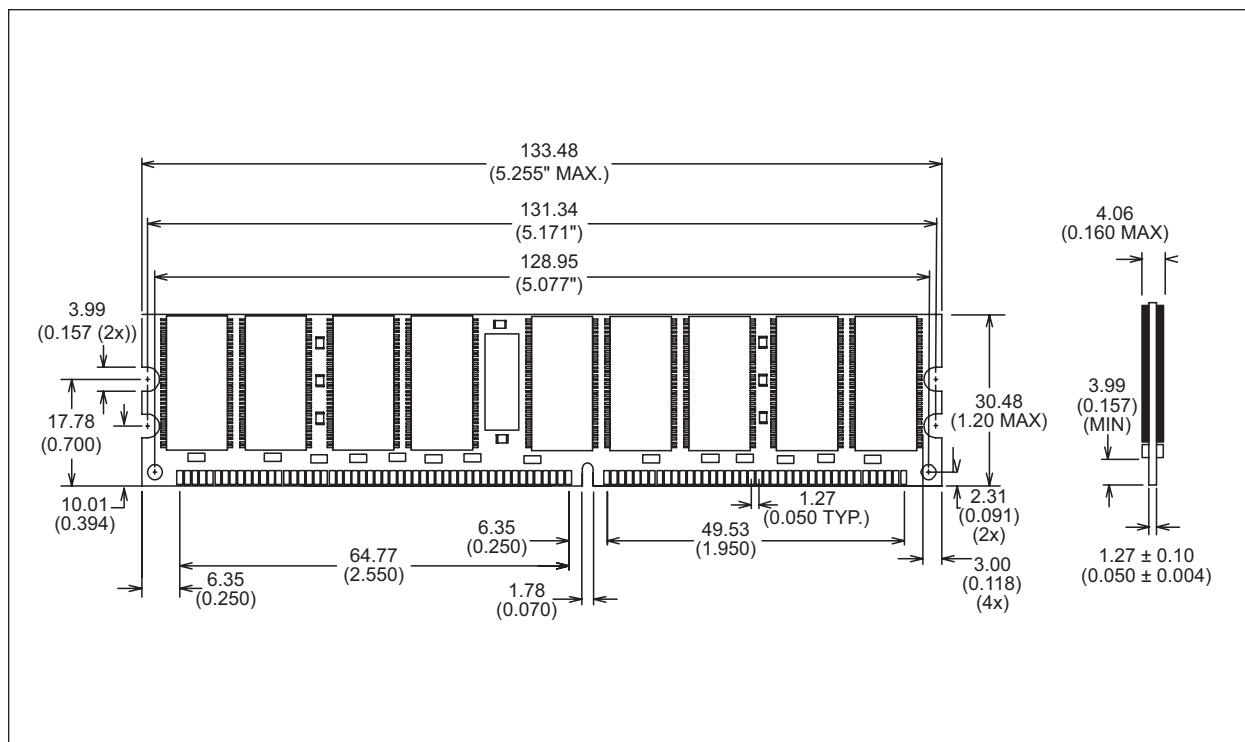
**W3EG7234S-D3**  
**-JD3**  
**-AJD3**

PRELIMINARY

### ORDERING INFORMATION FOR JD3

| Part Number     | Speed          | CAS Latency | t <sub>RCD</sub> | t <sub>RP</sub> | Height*       |
|-----------------|----------------|-------------|------------------|-----------------|---------------|
| W3EG7234S262JD3 | 133MHz/266Mb/s | 2           | 2                | 2               | 30.48 (1.20") |
| W3EG7234S265JD3 | 133MHz/266Mb/s | 2.5         | 3                | 3               | 30.48 (1.20") |
| W3EG7234S202JD3 | 100MHz/200Mb/s | 2           | 2                | 2               | 30.48 (1.20") |

### PACKAGE DIMENSIONS FOR JD3



\* ALL DIMENSIONS ARE IN MILLIMETERS AND (INCHES).



WHITE ELECTRONIC DESIGNS

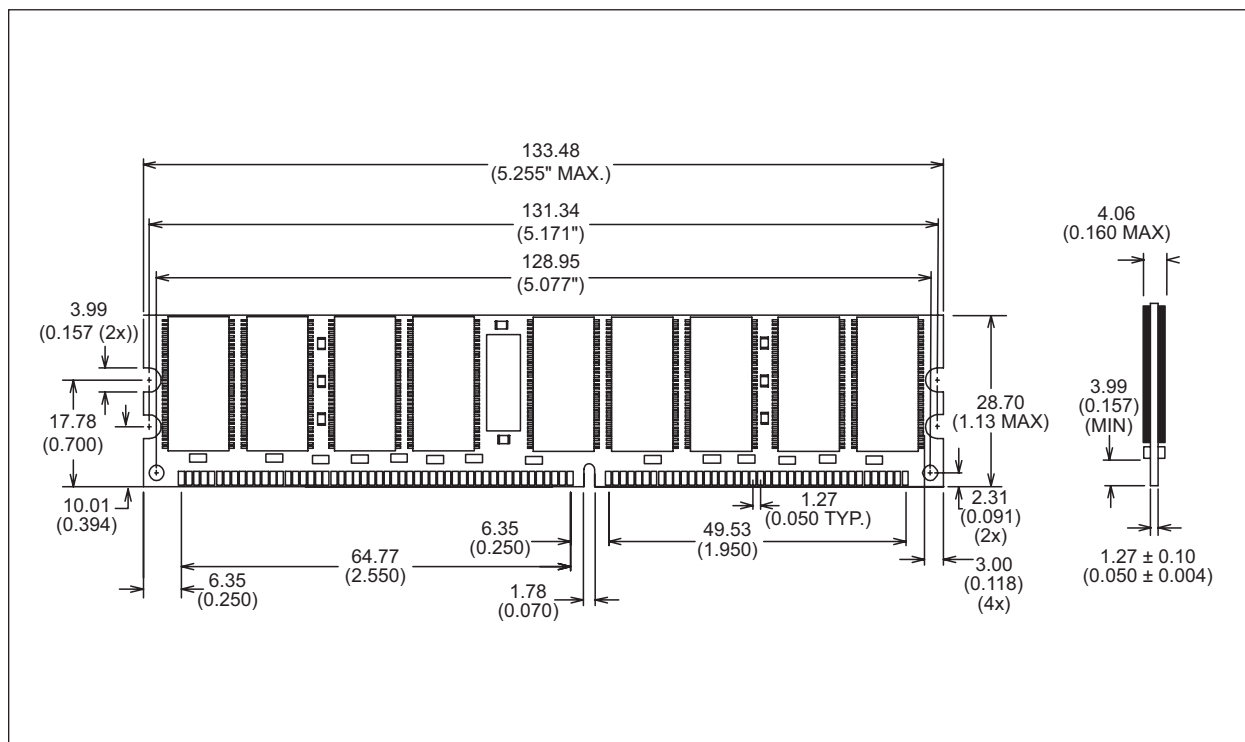
**W3EG7234S-D3**  
**-JD3**  
**-AJD3**

PRELIMINARY

### ORDERING INFORMATION FOR AJD3

| Part Number      | Speed          | CAS Latency | t <sub>RCD</sub> | t <sub>RP</sub> | Height*       |
|------------------|----------------|-------------|------------------|-----------------|---------------|
| W3EG7234S262AJD3 | 133MHz/266Mb/s | 2           | 2                | 2               | 28.70 (1.13") |
| W3EG7234S265AJD3 | 133MHz/266Mb/s | 2.5         | 3                | 3               | 28.70 (1.13") |
| W3EG7234S202AJD3 | 100MHz/200Mb/s | 2           | 2                | 2               | 28.70 (1.13") |

### PACKAGE DIMENSIONS FOR AJD3



\* ALL DIMENSIONS ARE IN MILLIMETERS AND (INCHES).



WHITE ELECTRONIC DESIGNS

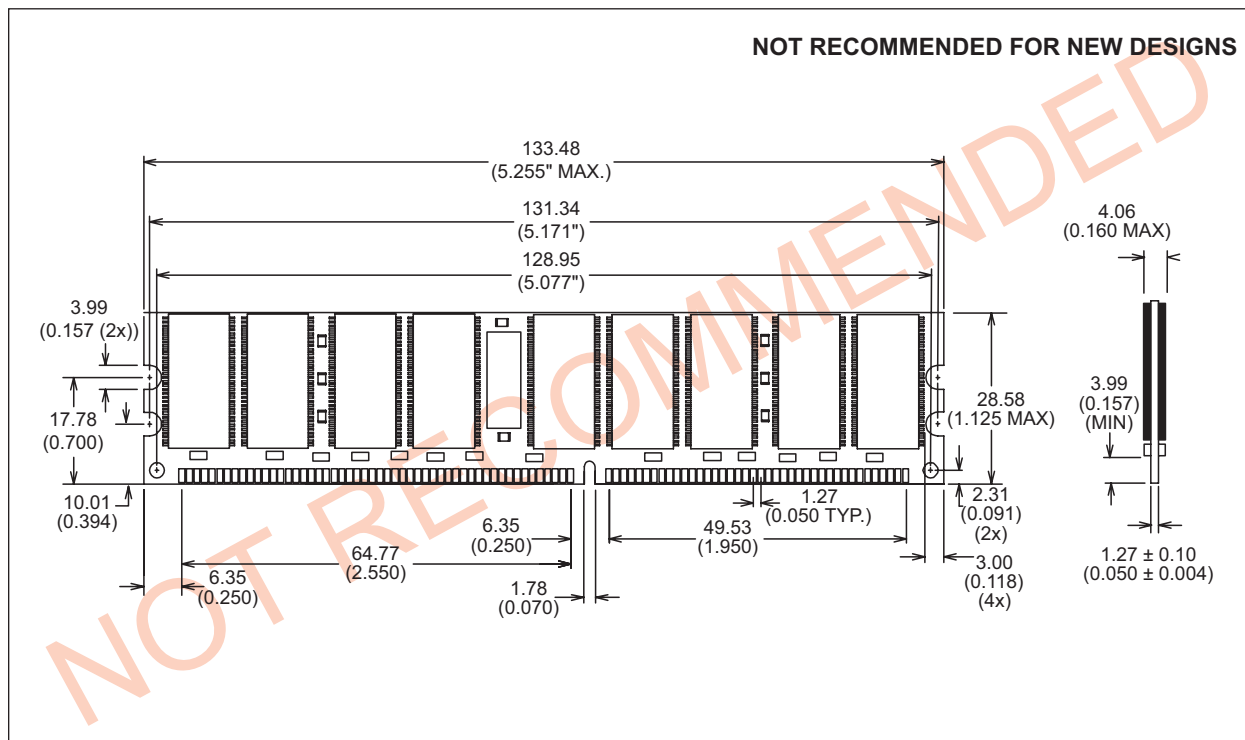
**W3EG7234S-D3**  
**-JD3**  
**-AJD3**

PRELIMINARY

### ORDERING INFORMATION FOR D3

| Part Number    | Speed          | CAS Latency | t <sub>RCD</sub> | t <sub>RP</sub> | Height*        |
|----------------|----------------|-------------|------------------|-----------------|----------------|
| W3EG7234S262D3 | 133MHz/266Mb/s | 2           | 2                | 2               | 28.58 (1.125") |
| W3EG7234S265D3 | 133MHz/266Mb/s | 2.5         | 3                | 3               | 28.58 (1.125") |
| W3EG7234S202D3 | 100MHz/200Mb/s | 2           | 2                | 2               | 28.58 (1.125") |

### PACKAGE DIMENSIONS FOR D3



\* ALL DIMENSIONS ARE IN MILLIMETERS AND (INCHES).



WHITE ELECTRONIC DESIGNS

**W3EG7234S-D3**  
**-JD3**  
**-AJD3**

*PRELIMINARY*

## Document Title

256MB - 32Mx72 DDR SDRAM REGISTERED, w/PLL

## Revision History

| Rev # | History                                                                                                                                                                                                                   | Release Date | Status      |
|-------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------|-------------|
| Rev A | Created                                                                                                                                                                                                                   | 5-21-02      | Advanced    |
| Rev 0 | 0.1 Updated CAP and I <sub>DD</sub> specs<br>0.2 Removed "ED" from Part Marking<br>0.3 Added JD3 and AJD3 Package Height Options<br>0.4 Moved datasheet from Advanced to Preliminary<br>0.5 Added new Document Title Page | 7-04         | Preliminary |
| Rev 1 | 1.1 Added AC specs                                                                                                                                                                                                        | 11-04        | Preliminary |
| Rev 2 | 2.1 Updated I <sub>DD</sub> specs                                                                                                                                                                                         | 12-04        | Preliminary |